

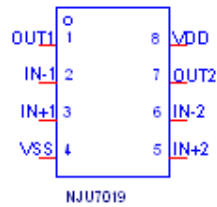
Device Modeling Report

COMPONENTS : OPERATIONAL AMPLIFIER (CMOS)
PART NUMBER : NJU7019
MANUFACTURER : NEW JAPAN RADIO



Bee Technologies Inc.

Spice Model



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*PART NUMBER: NJU7019
*MANUFACTURER: NEW JAPAN RADIO
*CMOS OPAMP
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.SUBCKT nju7019  OUT1 IN-1 IN+1 VSS IN+2 IN-2 OUT2 VDD
X_U1 IN+1 VSS IN-1 OUT1 VDD nju7019_s
X_U2 IN+2 VSS IN-2 OUT2 VDD nju7019_s
.ENDS nju7019
.SUBCKT nju7019_s  IN+ VSS IN- OUT VDD
M1      2 IN- 3 VDD MbreakPD3
M2      2 IN+ 4 VDD MbreakPD2
M3      VDD 1 2 VDD MbreakPD
M4      VDD 1 5 VDD MbreakPD
M5      VDD 1 6 VDD MbreakPD
M6      VDD 1 1 VDD MbreakPD
M7      5 5 VSS VSS MbreakND  W=3.2m  L=6u
M8      5 4 VSS VSS MbreakND3
M9      3 3 IN1 VSS MbreakND1
M10     4 3 IN2 VSS MbreakND1
M11     1 6 11 11 MbreakND  W=9m  L=6u
M12     6 6 VSS VSS MbreakND3
M13     7 5 VSS VSS MbreakND1
M14     VDD 7 7 VDD MbreakPD
M15     VDD 7 OUT VDD MbreakPD1
M16     OUT 4 VSS VSS MbreakND2
C1      OUT 1 5p
C2      OUT IN- 25p
C3      OUT 3 1p
C4      OUT 4 3.4p
R1      11 VSS 1.522k
R2      IN1 VSS 2.0k
R3      IN2 VSS 2.423k
I1      0 IN- 0.505p
I2      0 IN+ 1.5p

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X_U1      VSS 3 DbreakZ
X_U2      VSS 4 DbreakZ
.model MbreakND NMOS (LEVEL=3 VTO=0.9 RS=10.000E-3 RD=10.000E-3
+ RDS=1.0000E6 TOX=2.0000E-6 CGSO=4.000E-12 CGDO=1.000E-12
+ CBD=1.000E-12 RG=5 RB=1.0000E-3 KP=10E-6)
.model MbreakND1 NMOS (LEVEL=3 L=6u W=0.5 VTO=1 RS=10.000E-3
+ RD=10.000E-3 RDS=1.0000E6 TOX=2.0000E-6 CGSO=1.00E-12
+ CGDO=1.000E-12 CBD=2.5000E-11 RG=5 RB=1.0000E-3 KP=10E-6)
.model MbreakND2 NMOS (LEVEL=3 L=6u W=0.29m VTO=0.9 RS=10.000E-3
+ RD=10.000E-3 RDS=1.0000E6 TOX=2.0000E-6 CGSO=4.000E-12
+ CGDO=1.00E-12 CBD=1.000E-12 RG=5 RB=1.0000E-3 KP=10E-6)
.model MbreakND3 NMOS (LEVEL=3 L=6u W=3.2m VTO=0.9 RS=10.000E-3
+ RD=10.000E-3 RDS=1.0000E6 TOX=2.0000E-6 CGSO=1.000E-12
+ CGDO=1.000E-12 CBD=1.000E-12 RG=5 RB=1.0000E-3 KP=10E-6)
.model MbreakPD PMOS (LEVEL=3 L=6u W=0.023 VTO=-1 RS=10.000E-3
+ RD=10.000E-3 RDS=1.0000E6 TOX=2.0000E-6 CGSO=4.000E-12
+ CGDO=1.000E-12 CBD=1.000E-12 RG=5 RB=1.0000E-3 KP=1E-6)
.MODEL MbreakPD1 PMOS (LEVEL=3 L=6u W=0.00736 VTO=-0.9
+ RS=10.000E-3 RD=10.000E-3 RDS=1.00E6 TOX=2.0000E-6
+ CGSO=4.000E-12 CGDO=1.000E-12 CBD=1.000E-12 RG=5
+ RB=1.0000E-3 KP=1E-6)
.MODEL MbreakPD2 PMOS (LEVEL=3 L=6u W=0.001747 VTO=-1.5
+ RS=10.000E-3 RD=10.00E-3 RDS=1.06E6 TOX=2.0000E-6
+ CGSO=4.000E-12 CGDO=1.000E-12 CBD=1.00E-12 RG=5
+ RB=1.0000E-3 KP=1E-6)
.MODEL MbreakPD3 PMOS (LEVEL=3 L=6u W=0.001954 VTO=-1.5
+ RS=10.000E-3 RD=10.00E-3 RDS=1.E6 TOX=2.0000E-6 CGSO=4.000E-12
+ CGDO=1.000E-12 CBD=1.00E-12 RG=5 RB=1.0000E-3 KP=1E-6)
.ENDS nju7019_s
.SUBCKT DbreakZ  A K
D1 A K DF
DZ A2 A DR
VZ K A2 1
.MODEL DF D
.MODEL DR D
.ENDS DbreakZ
*$

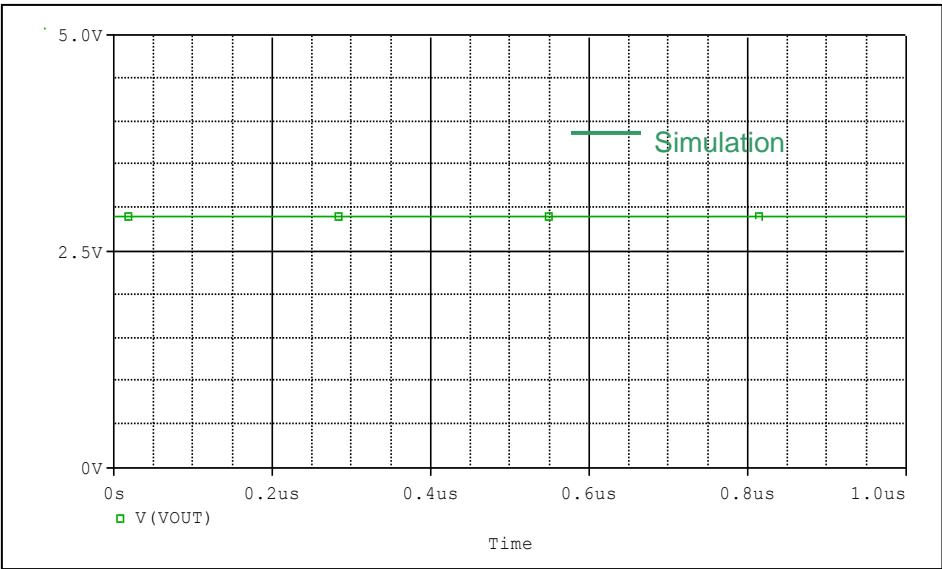
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MOSFET MODEL

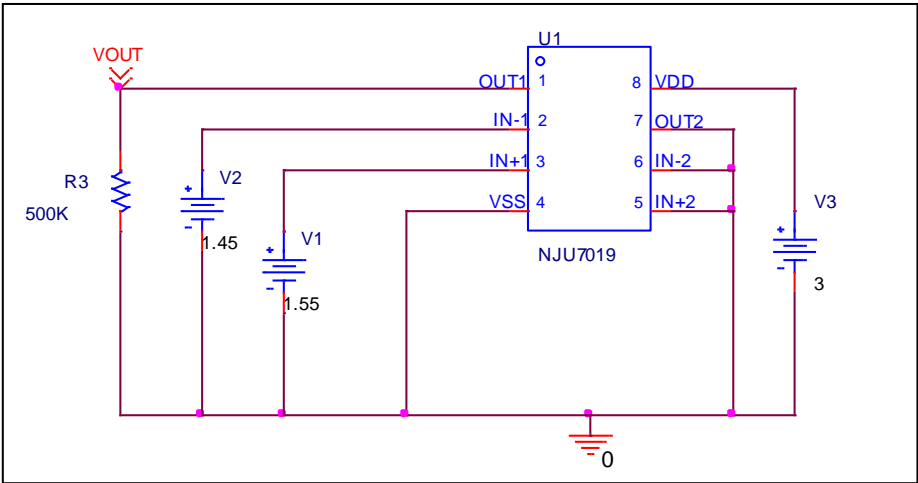
Pspice model parameter	Model description
LEVEL	
L	Channel Length
W	Channel Width
KP	Transconductance
RS	Source Ohmic Resistance
RD	Ohmic Drain Resistance
VTO	Zero-bias Threshold Voltage
RDS	Drain-Source Shunt Resistance
TOX	Gate Oxide Thickness
CGSO	Zero-bias Gate-Source Capacitance
CGDO	Zero-bias Gate-Drain Capacitance
CBD	Zero-bias Bulk-Drain Junction Capacitance
MJ	Bulk Junction Grading Coefficient
PB	Bulk Junction Potential
FC	Bulk Junction Forward-bias Capacitance Coefficient
RG	Gate Ohmic Resistance
IS	Bulk Junction Saturation Current
N	Bulk Junction Emission Coefficient
RB	Bulk Series Resistance
PHI	Surface Inversion Potential
GAMMA	Body-effect Parameter
DELTA	Width effect on Threshold Voltage
ETA	Static Feedback on Threshold Voltage
THETA	Modility Modulation
KAPPA	Saturation Field Factor
VMAX	Maximum Drift Velocity of Carriers
XJ	Metallurgical Junction Depth
UO	Surface Mobility

Output Voltage Swing

Simulation result



Evaluation Circuit

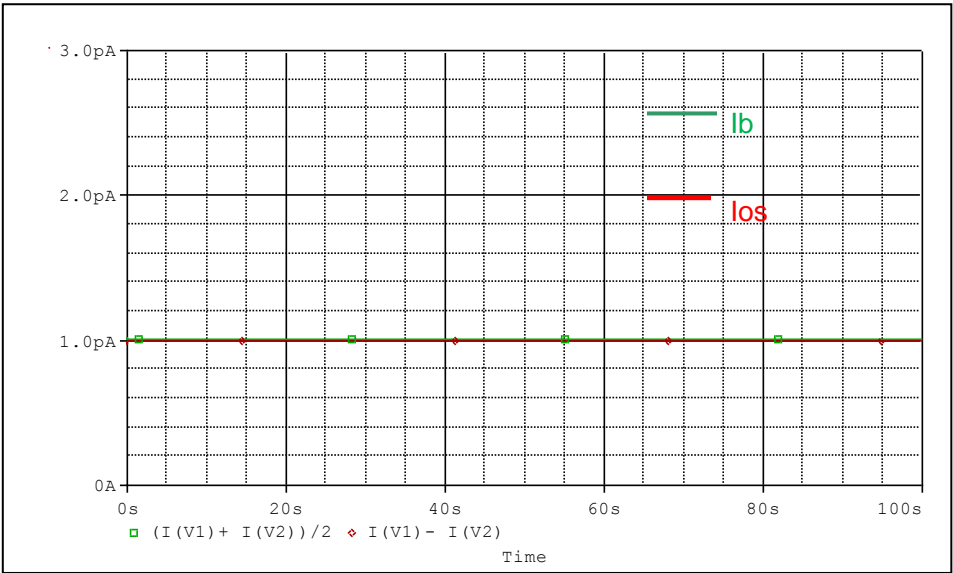


Comparison Table

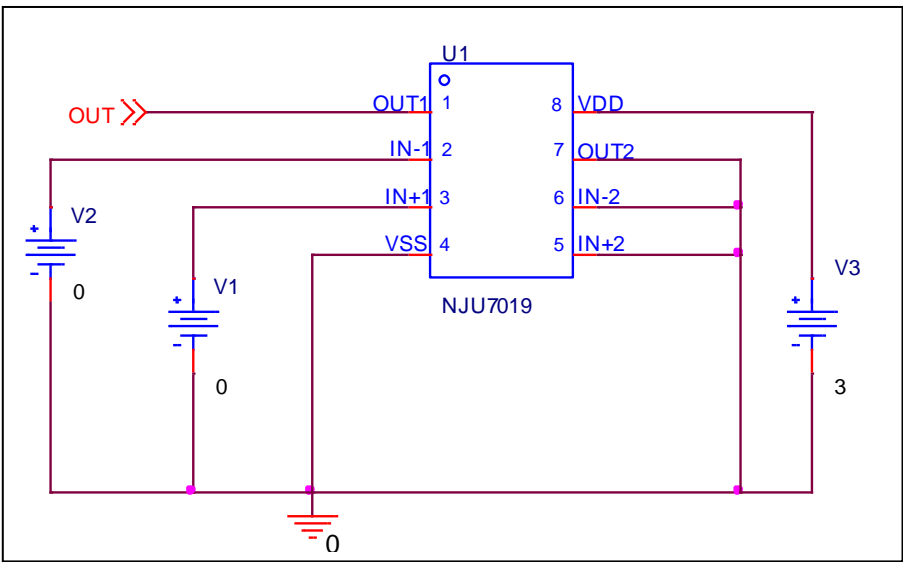
	Measurement	Simulation	%Error
V_{OM} (V)	2.900	2.898	-0.086

Input Current

Simulation result



Evaluation Circuit

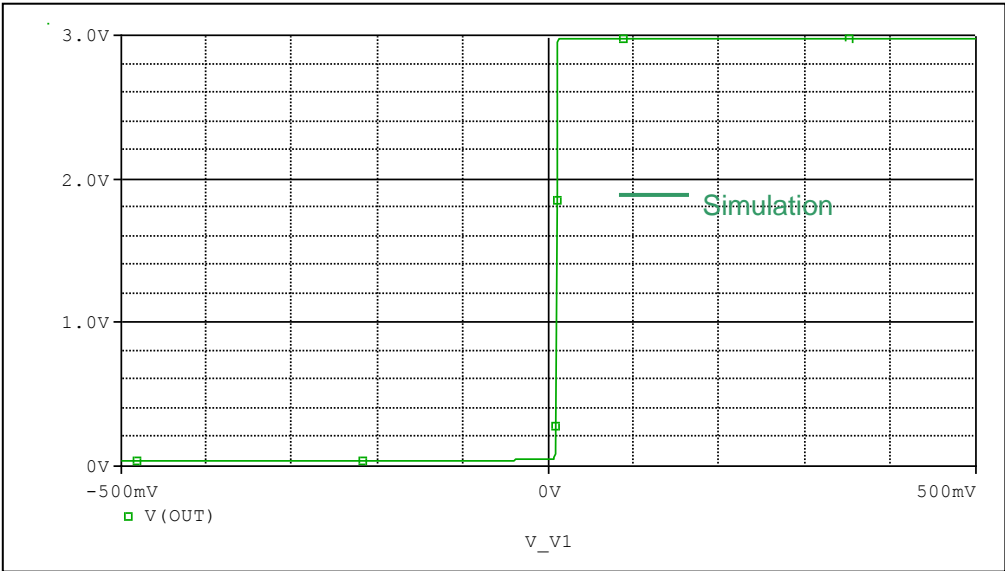


Comparison Table

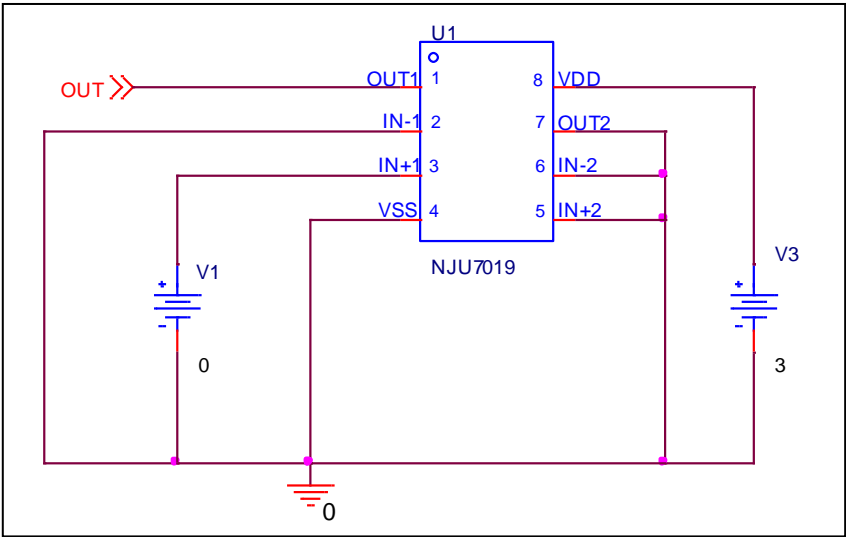
	Measurement	Simulation	% Error
I_b (pA)	1.000	0.995	-0.500
I_{os} (pA)	1.000	1.002	0.240

Input Offset Voltage

Simulation result



Evaluation Circuit

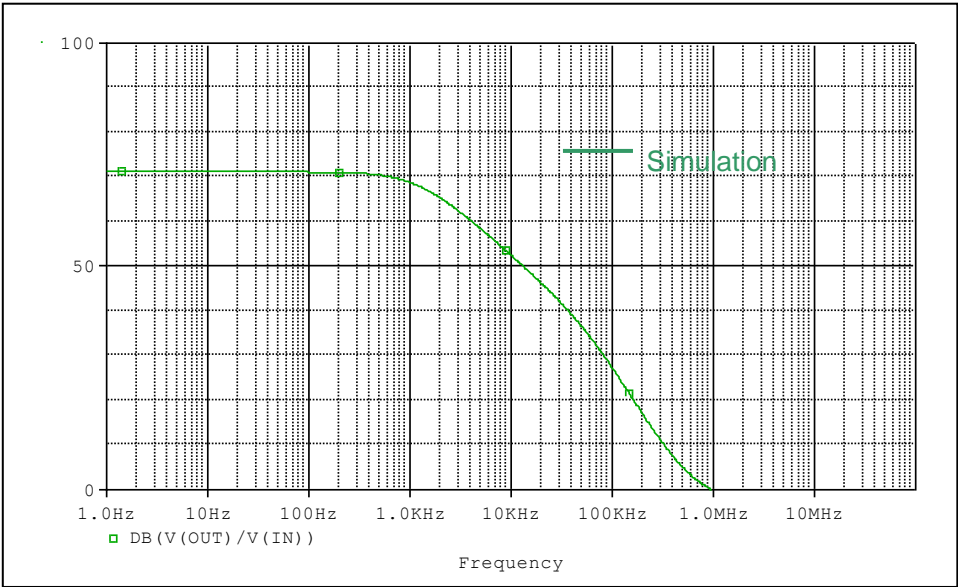


Comparison Table

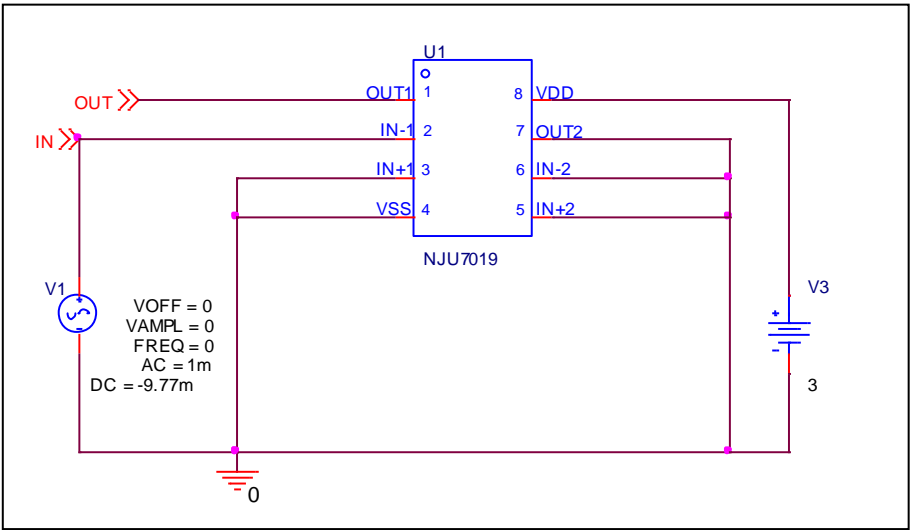
	Measurement	Simulation	%Error
V _{os} (mV)	10.000	9.770	-2.300

Open loop Voltage Gain

Simulation result



Evaluation Circuit

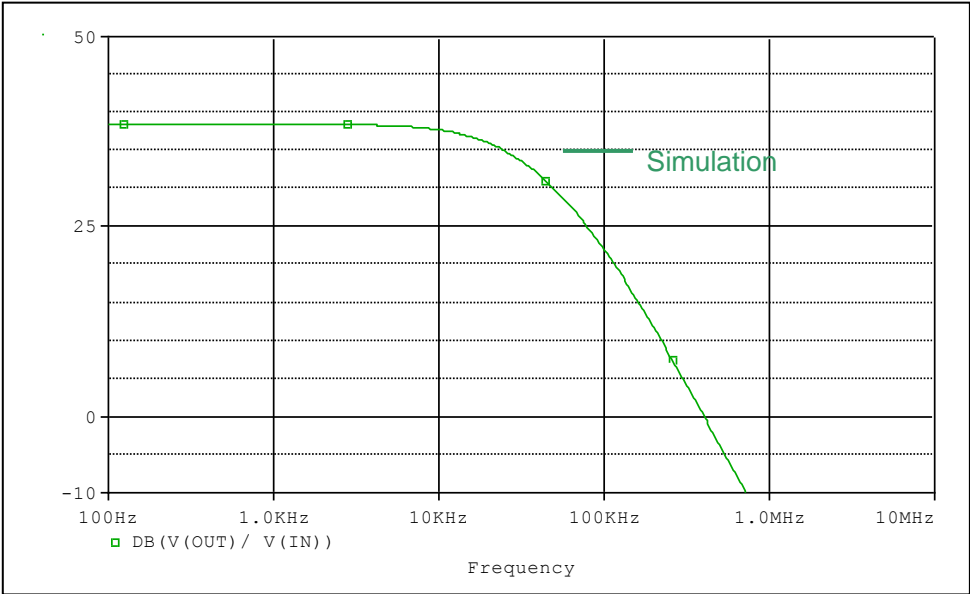


Comparison Table

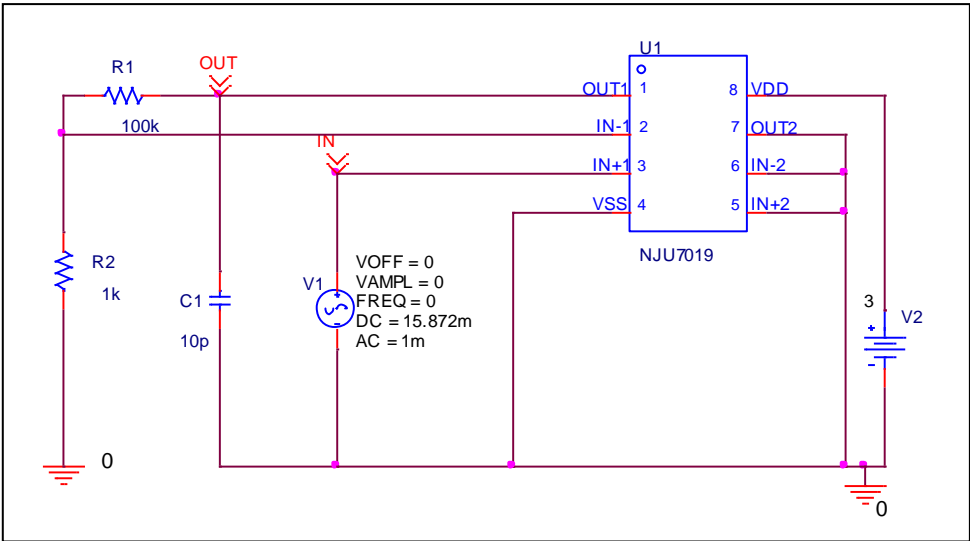
	Measurement	Simulation	%Error
Av (dB)	70.000	71.162	1.660

Unity Gain Frequency

Simulation result



Evaluation Circuit

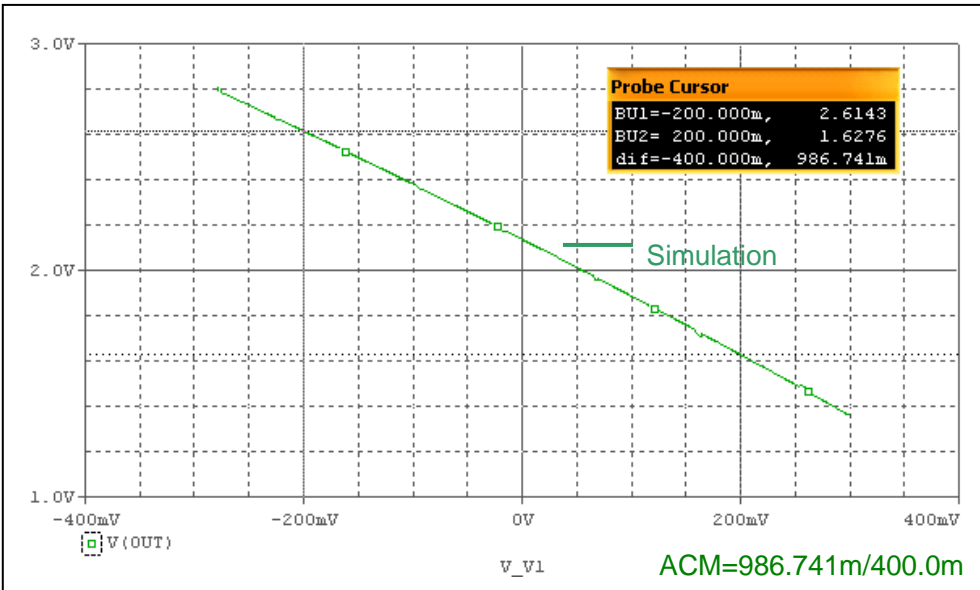


Comparison Table

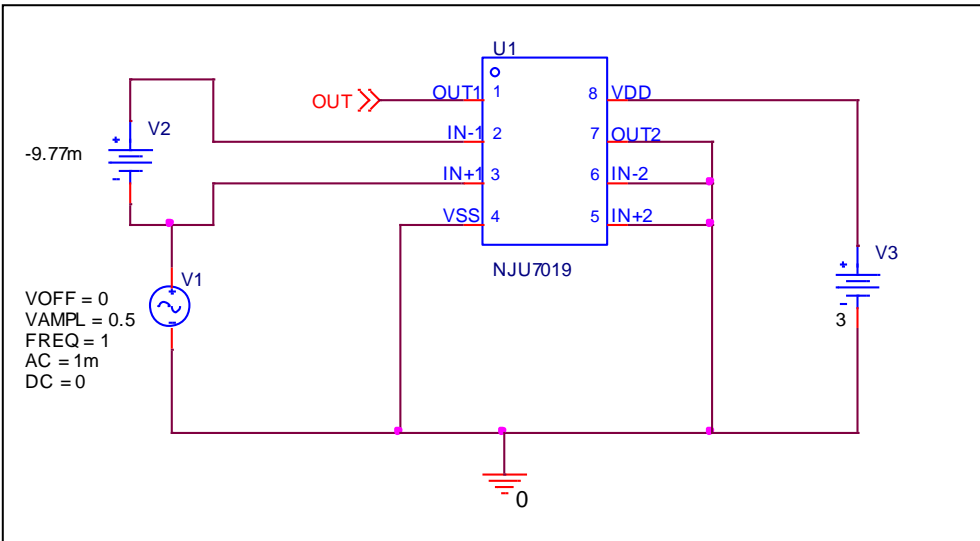
$A_v=40\text{dB}, C_L=10\text{pF}$	Measurement	Simulation	%Error
Ft(MHz)	0.400	0.403	0.750

Common-Mode Rejection Ratio

Simulation result



Evaluation Circuit



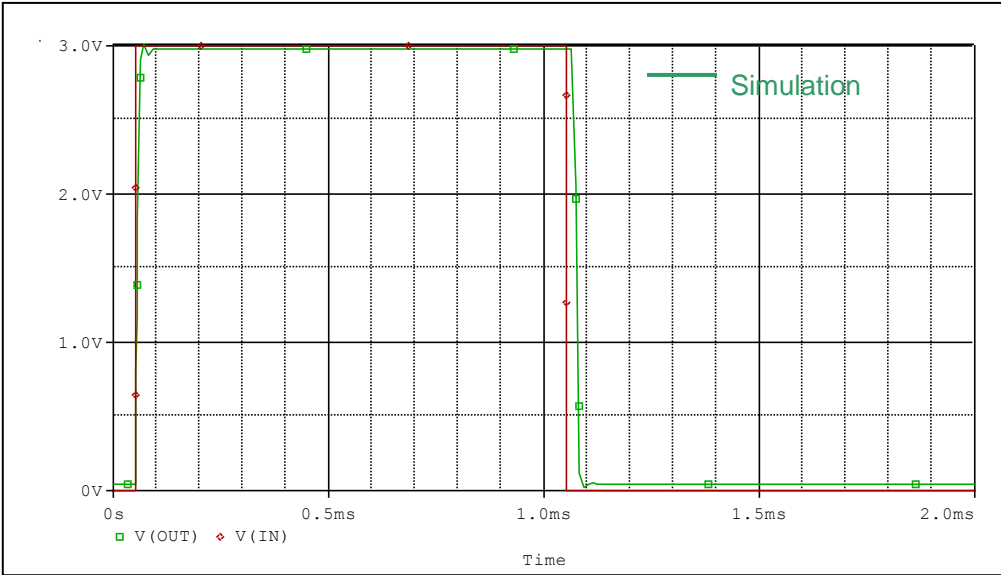
$$\text{CMRR} = \text{AV}/\text{ACM}$$

Comparison Table

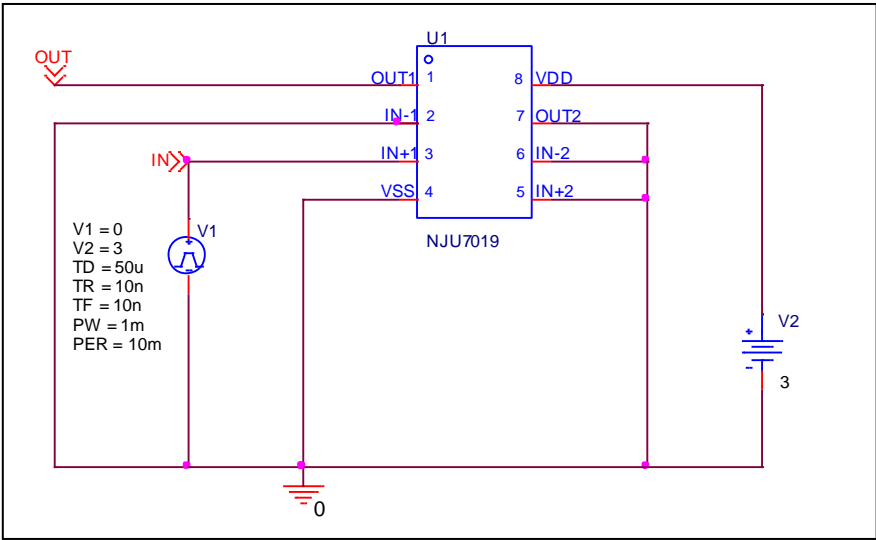
	Measurement	Simulation	%Error
CMRR (dB)	65.000	63.319	2.586

Slew Rate

Simulation result



Evaluation Circuit



Comparison Table

	Measurement	Simulation	% Error
SR (V/us)	0.250	0.252	0.650